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# FDG6322C Dual N & P Channel Digital FET

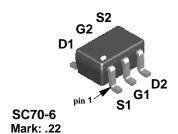
### **General Description**

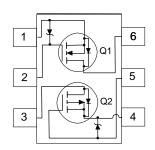
These dual N & P-Channel logic level enhancement mode field effect transistors are produced using ON Semiconductor's proprietary, high cell density, DMOS technology. This very high density process is especially tailored to minimizeon-state resistance. This device has been designed especially for low voltage applications as a replacement for bipolar digital transistors and small signal MOSFETs. Since bias resistors are not required, this dual digital FET can replace several different digital transistors, with different bias resistor values.

#### **Features**

- N-Ch 0.22 A, 25 V,  $R_{DS(ON)} = 4.0 \Omega$  @  $V_{GS} = 4.5 \text{ V}$ ,  $R_{DS(ON)} = 5.0 \Omega$  @  $V_{GS} = 2.7 \text{ V}$ .
- P-Ch -0.41 A,-25V,  $R_{DS(ON)} = 1.1~\Omega @ V_{GS} = -4.5V$ ,  $R_{DS(ON)} = 1.5~\Omega @ V_{GS} = -2.7V$ .
- Very small package outline SC70-6.
- Very low level gate drive requirements allowing direct operation in 3 V circuits (V<sub>GS(th)</sub> < 1.5 V).</p>
- Gate-Source Zener for ESD ruggedness (>6kV Human Body Model).







## **Absolute Maximum Ratings** T<sub>A</sub> = 25°C unless other wise noted

Symbol	Parameter	N-Channel	P-Channel	Units
V <sub>DSS</sub>	Drain-Source Voltage	25	-25	V
$V_{GSS}$	Gate-Source Voltage	8	-8	V
D	Drain Current - Continuous	0.22	-0.41	А
	- Pulsed	0.65	-1.2	
<b>)</b>	Maximum Power Dissipation (Note 1)	0.	W	
$T_J$ , $T_{STG}$	Operating and Storage Temperature Range	-55 to	°C	
ESD	Electrostatic Discharge Rating MIL-STD-883D Human Body Model (100pf / 1500 Ohm)	6		kV
THERMA	L CHARACTERISTICS			
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient (Note1)	4′	°C/W	

Symbol	Parameter	Conditions	Type	Min	Тур	Max	Units
OFF CHAR	ACTERISTICS		•			•	•
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$	N-Ch	25			V
		$V_{GS} = 0 \text{ V}, I_{D} = -250 \mu\text{A}$	P-Ch	-25			
$\Delta BV_{DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient	I <sub>D</sub> = 250 μA, Referenced to 25 °C	N-Ch		25		mV/°C
		I <sub>D</sub> = -250 μA, Referenced to 25 °C	P-Ch		-22		
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 0 V,	N-Ch			1	μA
		$T_J = 55^{\circ}C$				10	
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = -20 \text{ V}, \ V_{GS} = 0 \text{ V},$	P-Ch			-1	μA
		$T_J = 55^{\circ}C$				-10	
GSS	Gate - Body Leakage Current	$V_{GS} = 8 \text{ V}, \ V_{DS} = 0 \text{ V}$	N-Ch			100	nA
		$V_{GS} = -8 \text{ V}, \ V_{DS} = 0 \text{ V}$	P-Ch			-100	nA
ON CHARAC	CTERISTICS (Note 2)						
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$	N-Ch	0.65	0.85	1.5	V
		$V_{DS} = V_{GS}, I_{D} = -250 \mu\text{A}$	P-Ch	-0.65	-0.82	-1.5	
$\Delta V_{GS(th)}/\Delta T_{J}$	Gate Threshold Voltage Temp. Coefficient	I <sub>D</sub> = 250 μA, Referenced to 25 °C	N-Ch		-2.1		mV/°C
55(4.)		I <sub>D</sub> = -250 μA, Referenced to 25 °C	P-Ch		2.1		
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	$V_{GS} = 4.5 \text{ V}, I_D = 0.22 \text{ A}$	N-Ch		2.6	4	Ω
		T <sub>J</sub> =125°C			5.3	7	
		$V_{GS} = 2.7 \text{ V}, I_D = 0.19 \text{ A}$			3.7	5	
		$V_{GS} = -4.5 \text{ V}, I_{D} = -0.41 \text{ A}$	P-Ch		0.85	1.1	
		T <sub>J</sub> =125°C			1.2	1.9	
		$V_{GS} = -2.7 \text{ V}, I_D = -0.25 \text{ A}$			1.15	1.5	
I <sub>D(ON)</sub>	On-State Drain Current	$V_{GS} = 4.5 \text{ V}, \ V_{DS} = 5 \text{ V}$	N-Ch	0.22			Α
		$V_{GS} = -4.5 \text{ V}, \ V_{DS} = -5 \text{ V}$	P-Ch	-0.41			
g <sub>FS</sub>	Forward Transconductance	$V_{DS} = 5 \text{ V}, I_{D} = 0.22 \text{ A}$	N-Ch		0.2		S
		$V_{DS} = -5 \text{ V}, \ I_{D} = -0.5 \text{ A}$	P-Ch		0.9		
DYNAMIC CI	HARACTERISTICS						
C <sub>iss</sub>	Input Capacitance	N-Channel	N-Ch		9.5		pF
		$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V},$	P-Ch		62		
C <sub>oss</sub>	Output Capacitance	f = 1.0 MHz	N-Ch		6		
		P-Channel	P-Ch		34		
C <sub>rss</sub>	Reverse Transfer Capacitance	$V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V},$	N-Ch		1.3		
		f = 1.0 MHz	P-Ch		10		

## **Electrical Characteristics** (continued)

## SWITCHING CHARACTERISTICS (Note 2)

Symbol	Parameter	Conditions	Туре	Min	Тур	Max	Units
t <sub>D(on)</sub>	Tum - On Delay Time	N-Channel	N-Ch		5	10	nS
		$V_{DD} = 5 \text{ V}, I_{D} = 0.5 \text{ A},$	P-Ch		7	15	
ţ,	Turn - On Rise Time	$V_{GS}$ = 4.5 V, $R_{GEN}$ = 50 $\Omega$	N-Ch		4.5	10	nS
			P-Ch		8	16	
t <sub>D(off)</sub>	Turn - Off Delay Time	P-Channel	N-Ch		4	8	nS
		$V_{DD} = -5 \text{ V}, I_{D} = -0.5 \text{ A},$	P-Ch		55	80	
t,	Tum - Off Fall Time	$V_{GS}$ = -4.5 V, $R_{GEN}$ = 50 $\Omega$	N-Ch		3.2	7	nS
			P-Ch		35	60	
$Q_g$	Total Gate Charge	N-Channel	N-Ch		0.29	0.4	nC
		$V_{DS} = 5 \text{ V}, I_{D} = 0.22 \text{ A},$	P-Ch		1.1	1.5	
$Q_{gs}$	Gate-Source Charge	V <sub>GS</sub> = 4.5 V	N-Ch		0.12		nC
		P- Channel	P-Ch		0.31		
$Q_{gd}$	Gate-Drain Charge	$V_{DS} = -5 \text{ V}, I_{D} = -0.41 \text{ A},$	N-Ch		0.03		nC
		V <sub>GS</sub> = -4.5 V	P-Ch		0.29		
DRAIN-SC	DURCE DIODE CHARACTERISTICS AND MA	XIMUM RATINGS	<u> </u>				
I <sub>s</sub>	Maximum Continuous Drain-Source Diode Forward Current		N-Ch			0.25	Α
			P-Ch			-0.25	
V <sub>SD</sub>	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_{S} = 0.5 \text{ A} \text{ (Note 2)}$	N-Ch		0.8	1.2	V
	1						l

#### Notes:

 $V_{GS} = 0 \text{ V}, I_{S} = -0.5 \text{ A} \text{ (Note 2)}$ 

P-Ch

-0.85

-1.2

<sup>1.</sup>  $R_{g,N}$  is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{g,K}$  is guaranteed by design while  $R_{\text{loch}}$  is determined by the user's board design.  $R_{\text{BJA}} = 415^{\circ}\text{C/W}$  on minimum mounting pad on FR-4 board in still air. 2. Pulse Test: Pulse Width  $\leq 300 \mu\text{s}$ , Duty Cycle  $\leq 2.0\%$ .

## Typical Electrical Characteristics: N-Channel

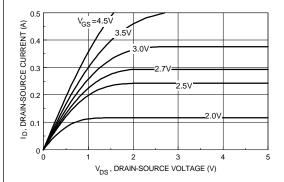


Figure 1. On-Region Characteristics.

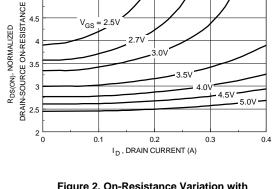


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

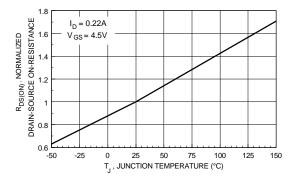


Figure 3. On-Resistance Variation with Temperature.

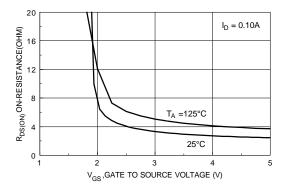


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

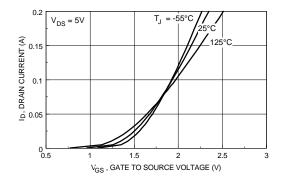


Figure 5. Transfer Characteristics.

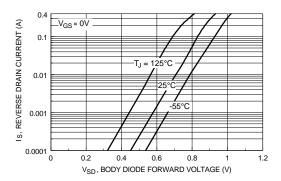


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

# **Typical Electrical Characteristics: N-Channel (continued)**

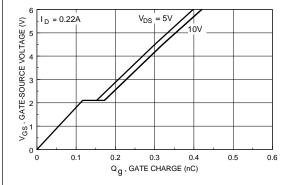


Figure 7. Gate Charge Characteristics.

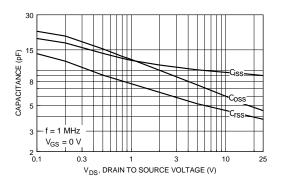


Figure 8. Capacitance Characteristics.

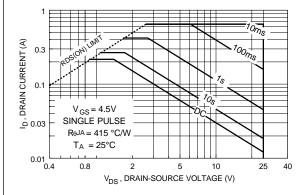


Figure 9. Maximum Safe Operating Area.

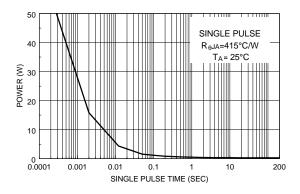


Figure 10. Single Pulse Maximum Power Dissipation.

## **Typical Electrical Characteristics: P-Channel**

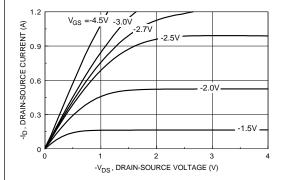


Figure 11. On-Region Characteristics.

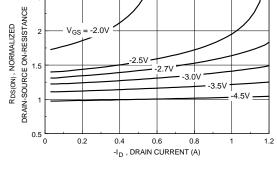


Figure 12. On-Resistance Variation with Drain Current and Gate Voltage.

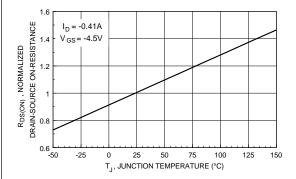


Figure 13. On-Resistance Variation with Temperature.

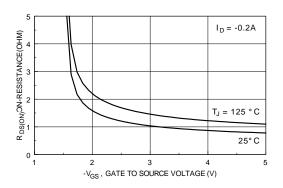


Figure 14. On-Resistance Variation with Gate-to-Source Voltage.

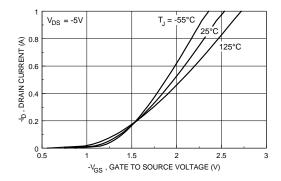


Figure 15. Transfer Characteristics.

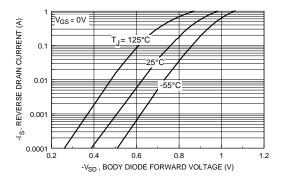


Figure 16. Body Diode Forward Voltage
Variation with Source Current
and Temperature.

## 1 Typical Electrical Characteristics: P-Channel (continued)

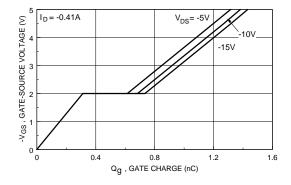


Figure 17. Gate Charge Characteristics.

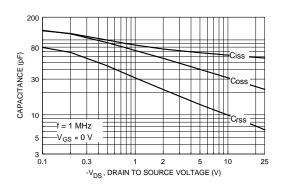


Figure 18. Capacitance Characteristics.

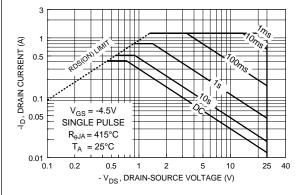


Figure 19. Maximum Safe Operating Area.

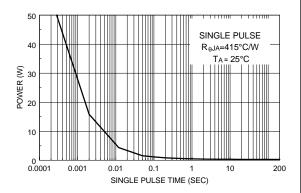


Figure 20. Single Pulse Maximum Power Dissipation.

# Typical Thermal Characteristics: N & P-Channel (continued)

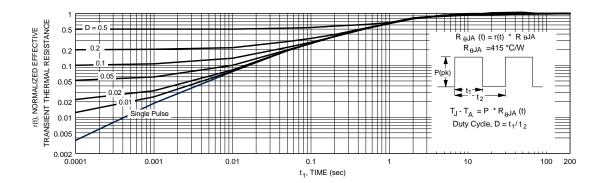


Figure 21. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in note 1. Transient thermalresponse will change depending on the circuit board design.

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